

Learning Patterns for Detection with Multiscale Scan Statistics

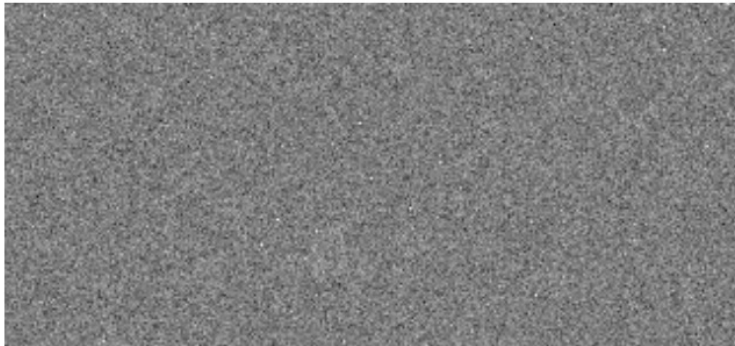
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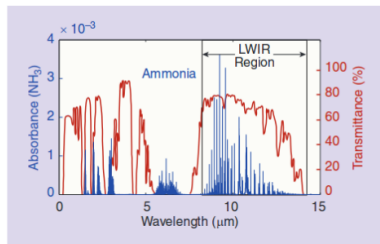
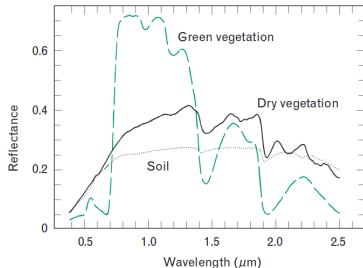
Work supported by NSF DMS-1712996

Hyperspectral Gas Detection



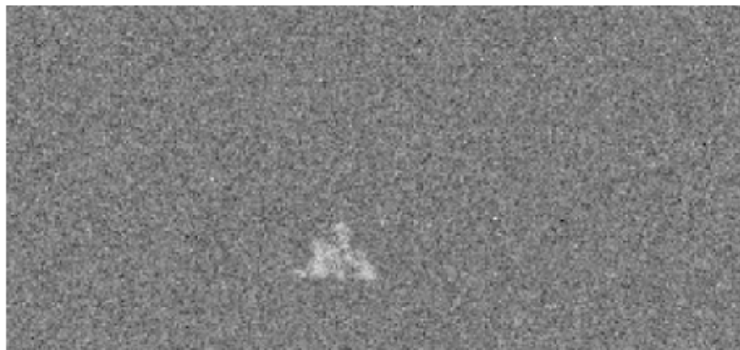
Hyperspectral Gas Detection

Each pixel of the image is a light spectrum, and we are interested in detecting a single chemical signature.



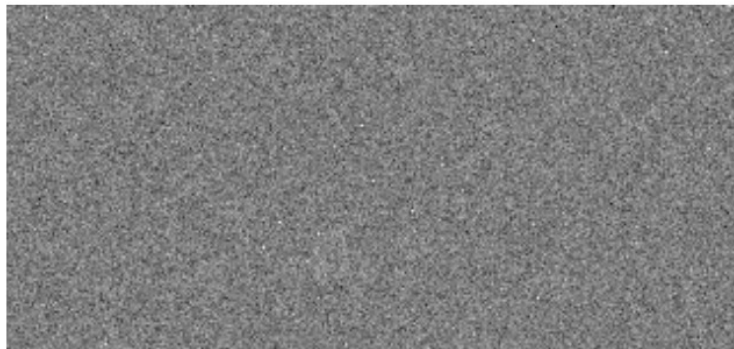
Images from [Manolakis et al. 2014, Manolakis & Shaw 2002]

Hyperspectral Gas Detection



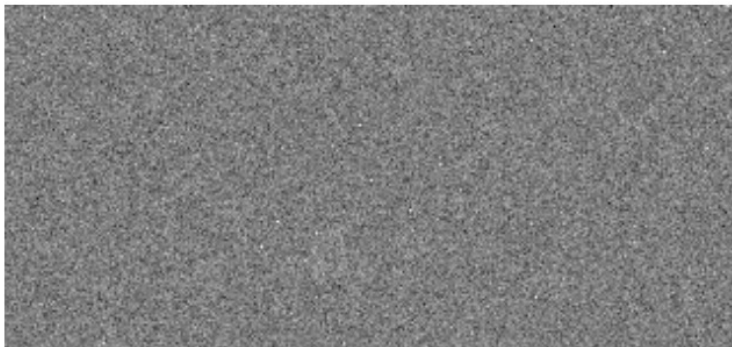
Gas signature level in each pixel. Dataset and chemical signature comparison code from Dimitris G. Manolakis and DTRA.

Hyperspectral Gas Detection



Decreased SNR by $\frac{1}{5}$ th. Can you see it?

Hyperspectral Gas Detection



If classification answers the question, "what am I seeing?"
detection answers the question, "do I see anything at all?"

Anomaly detection goals

Goal 1: *Reliably detect anomalous patterns within images beyond what the human eye can see—at the precise information theoretic limit.*

Detection applications

- ▶ Contaminant detection in water networks,
- ▶ real-time surveillance system,
- ▶ radiation monitoring,
- ▶ fire detection and other remote sensing applications,
- ▶ medical imaging and automated radiology,
- ▶ early detection of pathogen outbreaks.

Rectangular multiscale scan statistic

Scan every rectangle (vary location and scale) looking for abnormal concentrations [S, Arias-Castro '16].

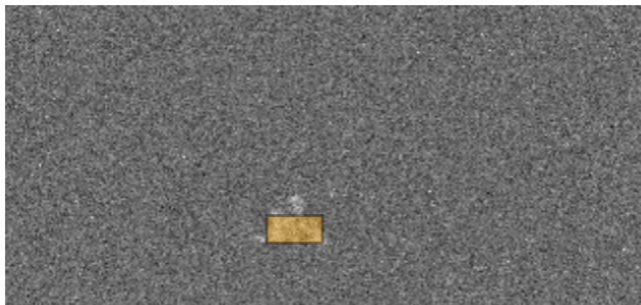


Figure: A rectangle over the active region.

Scan statistic

Represent image over $[-L, L] \times [-L, L]$ as matrix Y and consider scanning rectangle over pixels $[-H_0, H_0] \times [-H_1, H_1]$. Define the pattern to be

$$P_{k,l} = \frac{1}{\sqrt{(2H_0 + 1) \cdot (2H_1 + 1)}}$$

then the scan is the following convolution,

$$(P \star Y)_{k,l} = \sum_{k'=-H_0}^{H_0} \sum_{l'=-H_1}^{H_1} Y_{k-k', l-l'} P_{k',l'}, \quad \text{where defined.}$$

The single-scale scan statistic is

$$\hat{s} = \max_{k,l} (P \star Y)_{k,l}.$$

Other patterns

General pattern over the domain $\Omega = [-L, L]^d$ can be hidden in the noisy tensor.

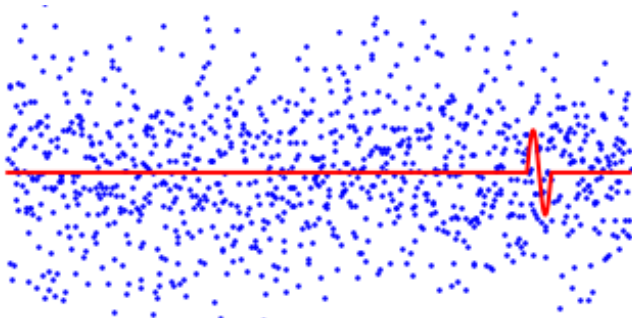
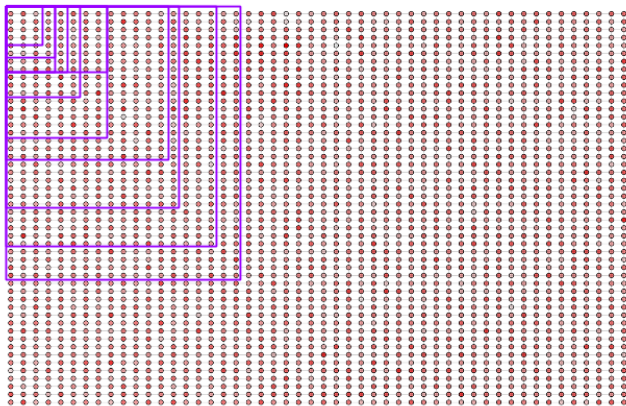


Figure: A simulated time series with an embedded sinusoidal signal with values on the y -axis ($d = 1$).

Multiscale scan

Scanning with many pattern dimensions, H_0, \dots, H_d , is called a multiscale scan.



How do we compare scan statistics at different scales?

Anomaly detection goals

Goal 2: *General purpose analysis for multiscale scan statistics for a large class of patterns.*

Multiple Tensors

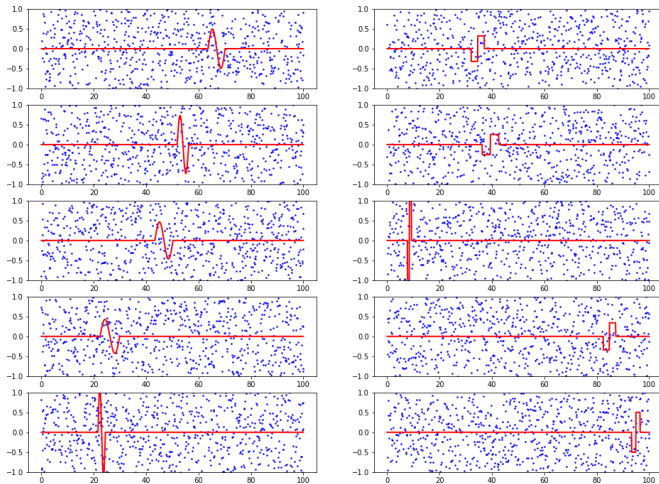


Figure: Multiple tensors, $i = 1, \dots, n$ ($n = 5$), with different locations and scales, and two possible patterns (left and right).

Anomaly detection goals

Goal 3: *Leverage database of tensors to simultaneously learn and detect anomalous patterns.*

Prior work

[Naus '65] scan statistics introduced for point cloud data

[Siegmund, Worsley '95] limit distribution of 1-**dimensional** scan

[Glaz and Zhang '04, Kabluchko '11] limit in d -dimensions

[Arias-Castro et al. '05, '11] scan for blob-like **patterns**

[Dumbgen, Spokoiny, '01] **scale adaptive** scan statistic ($d = 1$)

[S, Arias-Castro '16] scale adaptive rectangular scan

[Proksch et al. '17] scale adaptive smooth patterns

This work: learning and detecting **general smooth patterns** in a **database of tensors** with **scale adaptive methods**

Continuous model

- ▶ Pattern $f \in \mathcal{F} \subset C^1$ over $[-1, 1]^d$, $\|f\|_{L_2} = 1$.
- ▶ Data is random measure dX^i with domain $[-L, L]^d$.
- ▶ Scale dilation $f_h := h_{\bullet}^{-1/2} f(\cdot/h)$, $h_{\bullet} = \prod_j h_j$, $h \in \mathbb{R}^d$
- ▶ Null hypothesis: data is just noise (dW^i is d -dimensional Wiener process)
- ▶ Alternative hypothesis: there is a signal f at location t^i , and scale h^i .

$$H_0 : dX^i(\tau) = dW^i(\tau), i = 1, \dots, n$$

$$H_1 : dX^i(\tau) = \mu f_{h^i}(t^i - \tau) d\tau + dW^i(\tau)$$

for some $f \in \mathcal{F}$, and $(t^i, h^i) \in \mathcal{D}, i = 1, \dots, n$.

Continuous multiscale scan statistic

Convolution at scale h ,

$$(f_h \star dX^i)(t) = \int f_h(\tau) dX^i(t - \tau) = \int \frac{1}{\sqrt{h_\bullet}} f(\tau) dX^i(t - h\tau),$$

Scale corrected multiscale scan statistic:

$$s(X^i; f) := \max_{h \in \mathcal{H}} v_h \left(\max_{t \in \mathcal{T}_h} (f_h \star dX^i)(t) - v_h \right). \quad (1)$$

- ▶ $h \in \mathcal{H} := \times_j [1, L)$
- ▶ $t \in \mathcal{T}_h := \times_j [-(L - h_j), L - h_j]$
- ▶ $v_h = \sqrt{2 \sum_j \log(L/h_j)}$

Test if the pattern f centered at t and scaled by h is hidden within tensor X^i .

Learning patterns

Given a dataset of images $X^i, i = 1, \dots, n$ then can we also learn the pattern $f \in \mathcal{F}$?

$$S_n(X; \mathcal{F}) := \max_{f \in \mathcal{F}} \frac{1}{\sqrt{n}} \sum_{i=1}^n s(X^i; f) \quad (\text{PAMSS})$$

The pattern adapted multiscale scan statistic (PAMSS) averages the MSS for each tensor.

Smoothness conditions on \mathcal{F} are required: bounded variation (TVC) or average Hölder condition (AHC).

Smoothness assumptions

Assumption TVC: Define the isotropic total variation,

$$\|f\|_{\text{TV}} := \int_{\Omega} \|\nabla f(u)\|_2 du,$$

function are of bounded variation,

$$\exists \gamma_1 > 0 \text{ s.t. } \forall f \in \mathcal{F}, \quad \|f\|_{\text{TV}} \leq \gamma_1. \quad (\text{TVC})$$

or **Assumption AHC:** Define the Hölder functional,

$$A_{t,s}(f) := \int_{\Omega_L} |f(t-z) - f(s-z)|^2 dz.$$

functions have bounded average Hölder condition,

$$\exists 0 < \gamma_2 \leq 1 \text{ s.t. } \forall f \in \mathcal{F}, \quad A_{t,s}(f) \leq c_A \|t - s\|_2^{2\gamma_2}. \quad (\text{AHC})$$

Type 1 error control

We can simulate from the null distribution to obtain a significance level for

$$s(X^i; f) := \max_{h \in \mathcal{H}} v_h \left(\max_{t \in \mathcal{T}_h} (f_h \star dX^i)(t) - v_h \right). \quad (2)$$

[Dumbgen & Spokoiny '01] showed that under H_0 for L large enough

$$s(X^i, f) = O_{\mathbb{P}}(\log \log L)$$

for functions satisfying (TVC) in 1D.

We need a more precise control to analyze PAMSS (tail bound)— $s(X^i, f)$ is subexponential random variable.

SubGaussian process

Definition

We say that a random field, $\{Z(\iota)\}_{\iota \in \mathcal{I}}$, is a (zero mean) standard subGaussian process if there exists a constant $u_0 > 0$ such that

$$\mathbb{P} \{ |Z(\iota_0) - Z(\iota_1)| \geq u \} \leq 2 \exp \left(-\frac{u^2}{2\nu(\iota_0, \iota_1)} \right), \quad (3)$$

$$\mathbb{P} \{ Z(\iota_0) \geq u \} \leq \exp \left(-\frac{u^2}{2} \right), \quad (4)$$

for any $\iota_0, \iota_1 \in \mathcal{I}$, $u > u_0$, and $\nu(\iota_0, \iota_1) = \sqrt{\mathbb{E}(Z(\iota_0) - Z(\iota_1))^2}$, is the canonical distance.

Under H_0 , $\{(f_h \star dX^i)(t) : (t, h) \in \mathcal{D}\}$ is a subGaussian random field with canonical distance

$$\nu_f((h_0, t_0), (h_1, t_1)) := \|f_{h_0}(t_0 - \cdot) - f_{h_1}(t_1 - \cdot)\|_{L_2}.$$

Dudley's chaining

Define the **covering number** of metric space (\mathcal{I}, ν) , $\mathcal{N}(\mathcal{I}, \nu, \epsilon)$, to be the number of balls of ν -radius ϵ that is required to cover \mathcal{I} .

Theorem (Dudley's entropy (tail) bound)

$$\mathbb{P} \left\{ \sup_{\eta \in \mathcal{I}} Z(\eta) > u \cdot c \cdot \mathbf{D} + C \right\} \leq C e^{-\frac{u^2}{2}},$$

such that

$$\mathbf{D} = \int_0^\infty \sqrt{2 \log \mathcal{N}(\mathcal{I}, \nu, \epsilon)} d\epsilon$$

for universal constants c, C . Specifically, if

$$\mathcal{N}(\mathcal{I}, \nu, \epsilon) \leq \Gamma \epsilon^{-\rho}.$$

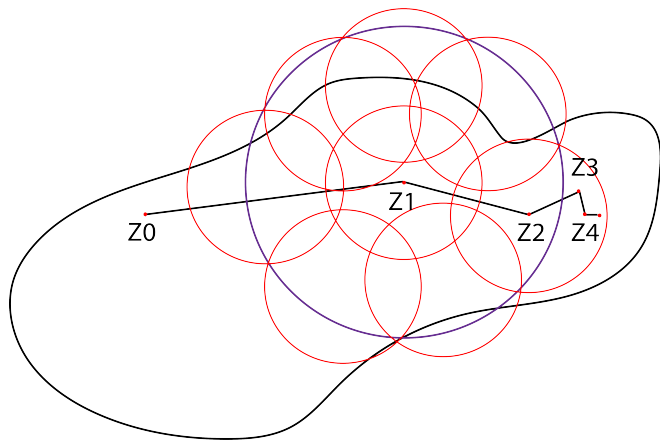
then (as $\Gamma \rightarrow \infty$)

$$\mathbf{D} = \sqrt{2 \log \Gamma} + o(1).$$

Dudley's chaining

Find a sequence (the chain) $\{\eta_k\}_{k=0}^{\infty}$ such that $\lim_{k \rightarrow \infty} \eta_k = \eta$,

$$\sup_{\eta \in \mathcal{I}} Z(\eta) = \sup_{\eta_0, \eta_1, \dots} Z(\eta_0) + (Z(\eta_1) - Z(\eta_0)) + (Z(\eta_2) - Z(\eta_1)) + \dots$$



Dudley's chaining

Find a sequence (the chain) $\{\eta_k\}_{k=0}^{\infty}$ such that $\lim_{k \rightarrow \infty} \eta_k = \eta$,

$$\sup_{\eta \in \mathcal{I}} Z(\eta) = \sup_{\eta_0, \eta_1, \dots} Z(\eta_0) + (Z(\eta_1) - Z(\eta_0)) + (Z(\eta_2) - Z(\eta_1)) + \dots$$

- ▶ $|Z(\eta_{i+1}) - Z(\eta_i)|$ is prop. to $\nu(\eta_{i+1}, \eta_i)$
- ▶ Choose covering layers such that \mathcal{N} grows like 2^{2^k}
- ▶ Variance of the bound is dominated by $Z(\eta_0)$

Chaining standardized suprema

Theorem

Let $Z(\eta)$ be a standard subGaussian process over an index set \mathcal{I} . Suppose that metric (\mathcal{I}, d_Z) has covering number, \mathcal{N} s.t.,

$$\mathcal{N}(\mathcal{I}, d_Z, \epsilon) \leq \Gamma \epsilon^{-\rho}. \quad (5)$$

Then there exists an $\Gamma_0 > 0$ such that for any $\Gamma \geq \Gamma_0$, the following supremum is bounded in probability,

$$\mathbb{P} \left\{ \sqrt{c_0 \log \Gamma} \left(\sup_{\eta \in \mathcal{I}} Z(\eta) - \sqrt{2 \log \Gamma} \right) - a_0 \log \log \Gamma > u \right\} \leq e^{-u}, \quad (6)$$

for $u > u_0$ where u_0, c_0, a_0 are constant depending on ρ (but not on Γ). In words, the supremum of such a subGaussian process is subexponential with location and rate parameter, $(2 \log \Gamma)^{1/2}$ (omitting the $\log \log$ term).

Proof sketch for chaining bound

For iid normals, $\{z_i\}_{i=1}^N$, from union bound

$$\mathbb{P} \left\{ \max_i z_i > \sqrt{2 \log N + u^2} \right\} \leq e^{-\frac{u^2}{2}}.$$

Generic chaining: $\sqrt{2 \log N + u^2} \leq u + \sqrt{2 \log N}/(2u)$

Our chaining: $\sqrt{2 \log N + u^2} \leq \sqrt{2 \log N} + u^2/(2\sqrt{2 \log N})$

$$\mathbb{P} \left\{ 2\sqrt{2 \log N} \left(\max_i z_i - \sqrt{2 \log N} \right) > u \right\} \leq e^{-u}.$$

Modify chain so that

- (1) start the chain at a deeper level (N large enough)
- (2) make the covers grow slowly $\mathcal{N} \leq a^{a^k}$ for $a \rightarrow 1$.

Main Theorem

Theorem

Let \mathcal{F} be finite and assume that either all functions in \mathcal{F} satisfy either (TVC) or (AHC). Let

$$F_n(\delta) := \begin{cases} \sqrt{K \log \left(\frac{|\mathcal{F}|}{\delta} \right)}, & \log |\mathcal{F}| \leq \frac{n}{K} + \log \delta \\ \frac{K}{\sqrt{n}} \log \left(\frac{|\mathcal{F}|}{\delta} \right), & \log |\mathcal{F}| > \frac{n}{K} + \log \delta \end{cases} \quad (7)$$

then for some constant K , under H_0 ,

$$\mathbb{P} \{ S_n(X, \mathcal{F}) > F_n(\delta) \cdot \log \log L \} \leq \delta. \quad (8)$$

Proof of main theorem

Lemma

Then, under the above conditions, there is a constant C depending on d alone such that

1. *Suppose that (TVC) holds for the class \mathcal{F} , then*

$$\nu_{\mathcal{F}}((t, h), (t', h'))^2 \leq C \gamma_1 \left(\left\| \frac{t - t'}{h} \right\|_2^2 + \left(\sqrt{\frac{h'_{\bullet}}{h_{\bullet}}} - 1 \right)^2 \right).$$

2. *[Proksch et al. '16] Suppose that (AHC) holds for the class \mathcal{F} , then*

$$\nu_{\mathcal{F}}((t, h), (t', h'))^2 \leq C \left(\left\| \frac{t_j - t'_j}{h_j} \right\|_{2\gamma_2}^{2\gamma_2} + \left\| \frac{h_j - h'_j}{\sqrt{h_j h'_j}} \right\|_{2\gamma_2}^{2\gamma_2} \right).$$

Proof of main theorem

Lemma

Suppose that $f \in \mathcal{F}$ satisfies either (TVC) or (AHC). Let $\ell \in \{0, \dots, \lfloor \log_2 L \rfloor\}^d$, and $\mathcal{H}_2(\ell) = \times_j [2^{\ell_j}, 2^{\ell_j+1}]$. Then

$$\mathbb{P} \left\{ c_1 \cdot \max_{h \in \mathcal{H}_\ell, t \in \mathcal{T}_h} v_h \left((f_h \star dX^i)(t) - v_h \right) - a_1 \log \log L > u \right\} \leq e^{-u}$$

for constants $a_1, c_1 > 0$ depending on γ, d only.

With the union bound over ℓ ,

$$\mathbb{P} \left\{ c_2 \cdot \frac{s_n(X^i, f)}{\log \log L} - a_2 > u \right\} \leq e^{-u},$$

then use subexponential Bernstein inequality.

Asymptotic Distinguishability

Corollary

Suppose that $\log |\mathcal{F}| = o(n)$, and recall that under the alternative hypothesis, H_1 , X^i has an embedded pattern f at scale h^i and $v_{h^i}^2 = \sum_j \log(L/h_j^i)$, and the noise is a standard Wiener process. Suppose also that $h_j^i \leq L^c$ for some $0 \leq c < 1$ for all i, j , then the PAMSS is asymptotically powerful (has diminishing probability of type 1 and type 2 error) if

$$\mu - \sqrt{2} \cdot \frac{\sum_{i=1}^n v_{h^i}^2}{\sum_{i=1}^n v_{h^i}} \rightarrow \infty. \quad (9)$$

We take this result to mean that as long as the function class, $|\mathcal{F}|$, does not grow exponentially in n , we achieve asymptotic power under the same conditions as if $|\mathcal{F}| = 1$.

Summary

- ▶ Proposed the Pattern Adapted Multiscale Scan Statistic for learning anomalous patterns
- ▶ We proved a refined concentration result for the supremum of subGaussian processes
- ▶ We controlled the error probabilities for the PAMSS showing that it can learn the function from a class for free as long as $n \gg \log |\mathcal{F}|$

For a link to this paper: <http://jsharpna.github.io>

Thanks!